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MT4946 N-Channel PowerTrench<sup>®</sup> MOSFET

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**60V, 5A, ' , m**Ω

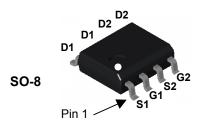
# **General Description**

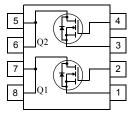
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low  $r_{\text{DS}(\text{ON})}$  and fast switching speed.

#### Features

- Max  $r_{DS(on)}$  = 38mΩ,  $V_{GS}$  = 10V,  $I_D$  = 5A
- Max  $r_{DS(on)}$  = 42mΩ,  $V_{GS}$  = 4.5V,  $I_D$  = 4A
- Low gate charge
- 100% R<sub>G</sub> tested
- RoHS Compliant







### MOSFET Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V <sub>DS</sub>	Drain to Source Voltage		60	V
V <sub>GS</sub>	Gate to Source Voltage		±20	V
	Drain Current Continuous	(Note 1a)	5	А
I <sub>D</sub>	Pulsed		20	A
E <sub>AS</sub>	Single Pulse Avalache Energy	(Note 2)	32	mJ
P <sub>D</sub>	Power Dissipation for Single Operation		2	W
	Derate above 25°C		13	mW/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature		-55 to 150	°C
Therma	Characteristics			
$R_{\thetaJA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	65	°C/W
R <sub>0.IC</sub>	Thermal Resistance, Junction-to-Case	(Note 1)	40	°C/W

# Package Marking and Ordering Information

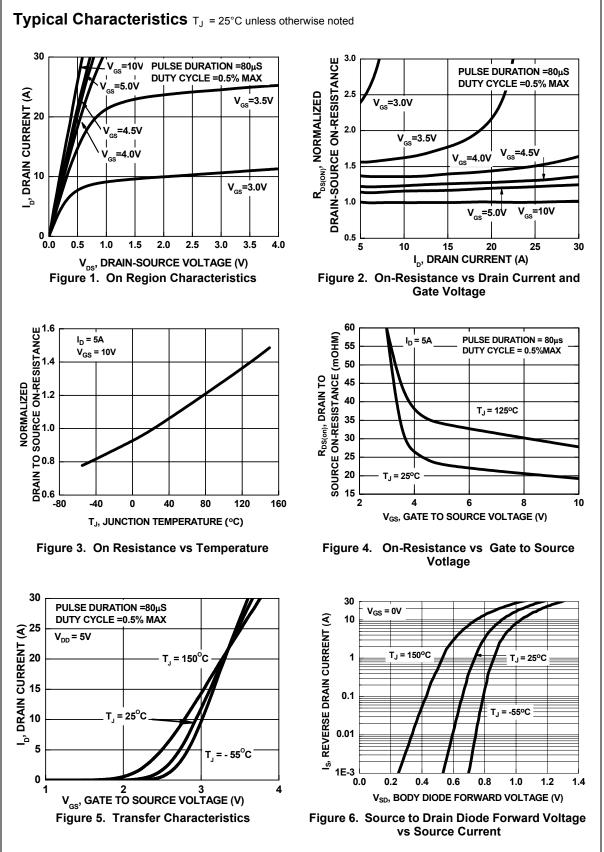
Device Marking	Device	Package	Reel Size	Tape Width	Quantity
MT4946	MT4946	SO-8	330mm	12mm	2500 units

BV <sub>DSS</sub>		Test Conditions	Min	Тур	Max	Units
BV <sub>DSS</sub>	acteristics					
ABV <sub>DSS</sub>	Drain to Source Breakdown Voltage	I <sub>D</sub> = 250μA, V <sub>GS</sub> = 0V 60				V
	Breakdown Voltage Temperature	$I_D = 250 \mu A$ , referenced to				
$\Delta T_{J}$	Coefficient	25°C		23		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 48V$ $V_{GS} = 0V$ $T_J = 125^{\circ}C$			1 250	μA
000	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA
I <sub>GSS</sub>		VGS 120V,VDS OV			1100	10.4
	ICTERISTICS (Note 3)				•	
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$ 1.0		1.5	2.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 250μA, referenced to 25°C		- 4.3		mV/°C
		V <sub>GS</sub> = 10V, I <sub>D</sub> = 5A		38	40	
r	Drain to Source On Resistance	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 4A		42	45	mΩ
r <sub>DS(on)</sub>	Drain to Source On Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 5A, T <sub>J</sub> = 125°C		39	42	- 11152
Dvnamic	Characteristics					
C <sub>iss</sub>	Input Capacitance			475	970	pF
C <sub>oss</sub>	Output Capacitance	$-V_{\rm DS} = 60V, V_{\rm GS} = 0V,$		50	70	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	f = 1.0MHz		35	45	pF
R <sub>G</sub>	Gate Resistance	f = 1MHz		0.9	1.6	Ω
	g Characteristics (Note 3)					
				5	10	ne
t <sub>d(on)</sub>	Turn-On Delay Time			5 9	10	ns
t <sub>d(on)</sub> t <sub>r</sub>	Turn-On Delay Time Rise Time	$V_{DD} = 60V, I_D = 5A$ $V_{CS} = 10V, R_{CS} = 33\Omega$		9	18	ns
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub>	Turn-On Delay Time Rise Time Turn-Off Delay Time	$V_{DD} = 60V, I_D = 5A$ $V_{GS} = 10V, R_{GS} = 33\Omega$		9 42	18 68	ns ns
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub>	Turn-On Delay Time Rise Time	$V_{GS} = 10V, R_{GS} = 33\Omega$ $V_{DS} = 60V, V_{GS} = 10V,$		9	18	ns
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub>	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge	$V_{GS} = 10V, R_{GS} = 33\Omega$ $V_{DS} = 60V, V_{GS} = 10V,$ $I_D = 5A$		9 42 21 9.2	18 68 34	ns ns ns
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>g</sub>	Turn-On Delay Time         Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge         Total Gate Charge	$V_{GS} = 10V, R_{GS} = 33\Omega$ $V_{DS} = 60V, V_{GS} = 10V,$ $I_D = 5A$ $V_{DS} = 60V, V_{GS} = 5V,$		9 42 21	18 68 34 13	ns ns ns nC
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>gs</sub>	Turn-On Delay Time Rise Time Turn-Off Delay Time Fall Time Total Gate Charge	$V_{GS} = 10V, R_{GS} = 33\Omega$ $V_{DS} = 60V, V_{GS} = 10V,$ $I_D = 5A$		9 42 21 9.2 5.0	18 68 34 13	ns ns ns nC nC
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Turn-On Delay Time         Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge         Total Gate Charge         Gate to Source Gate Charge         Gate to Drain "Miller" Charge	$V_{GS} = 10V, R_{GS} = 33\Omega$ $V_{DS} = 60V, V_{GS} = 10V,$ $I_D = 5A$ $V_{DS} = 60V, V_{GS} = 5V,$		9 42 21 9.2 5.0 1.5	18 68 34 13	ns ns nC nC nC
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub> <b>Drain-So</b>	Turn-On Delay Time         Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge         Total Gate Charge         Gate to Source Gate Charge         Gate to Drain "Miller" Charge         urce Diode Characteristics	$V_{GS} = 10V, R_{GS} = 33\Omega$ $V_{DS} = 60V, V_{GS} = 10V,$ $I_D = 5A$ $V_{DS} = 60V, V_{GS} = 5V,$ $I_D = 5A$		9 42 21 9.2 5.0 1.5	18 68 34 13	ns ns nC nC nC
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Turn-On Delay Time         Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge         Total Gate Charge         Gate to Source Gate Charge         Gate to Drain "Miller" Charge	$V_{GS} = 10V, R_{GS} = 33\Omega$ $V_{DS} = 60V, V_{GS} = 10V,$ $I_D = 5A$ $V_{DS} = 60V, V_{GS} = 5V,$ $I_D = 5A$		9 42 21 9.2 5.0 1.5 2.0	18 68 34 13 7	ns ns nC nC nC
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub> Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub> <b>Drain-So</b>	Turn-On Delay Time         Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge         Total Gate Charge         Gate to Source Gate Charge         Gate to Drain "Miller" Charge         urce Diode Characteristics	$V_{GS} = 10V, R_{GS} = 33\Omega$ $V_{DS} = 60V, V_{GS} = 10V,$ $I_{D} = 5A$ $V_{DS} = 60V, V_{GS} = 5V,$ $I_{D} = 5A$ $I_{SD} = 5A$ (Note 4)		9 42 21 9.2 5.0 1.5 2.0 0.9	18 68 34 13 7 1.25	ns ns nC nC nC v

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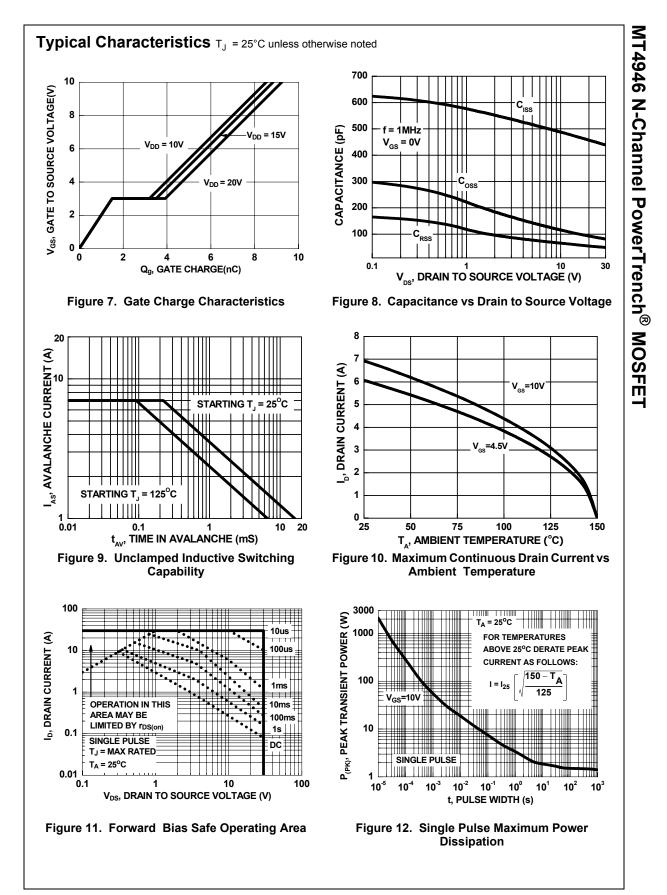
Scale 1 : 1 on letter size paper

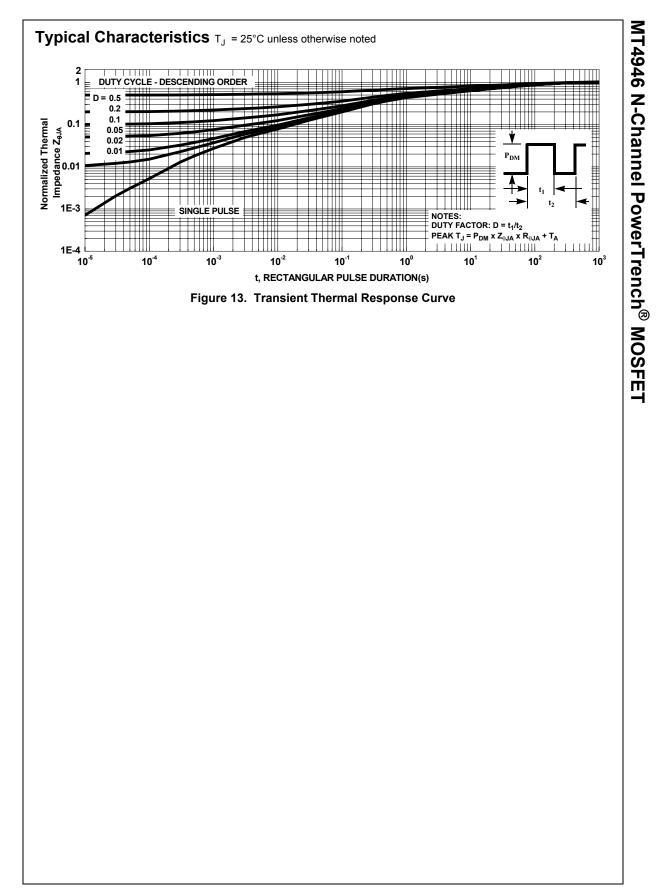
Starting T<sub>J</sub> = 25°C, L = 1mH, I<sub>AS</sub> = 8A, V<sub>DD</sub> = 27V, V<sub>GS</sub> = 10V.
 Pulse Test:Pulse Width <300μS, Duty Cycle <2%.</li>
 Is Continuous Source Current (Body Diode) > 5A. Ism : Pulsed Source Current (Body Diode)>15A

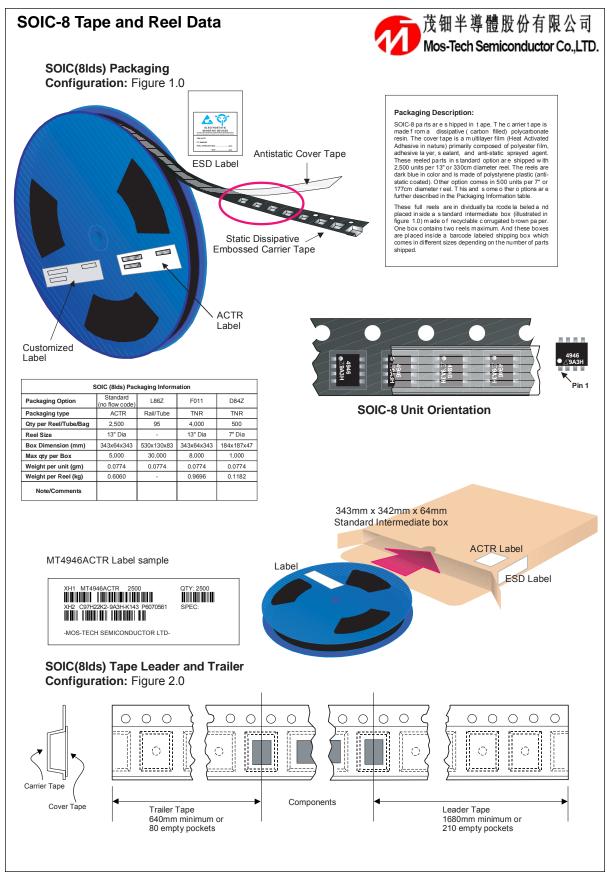


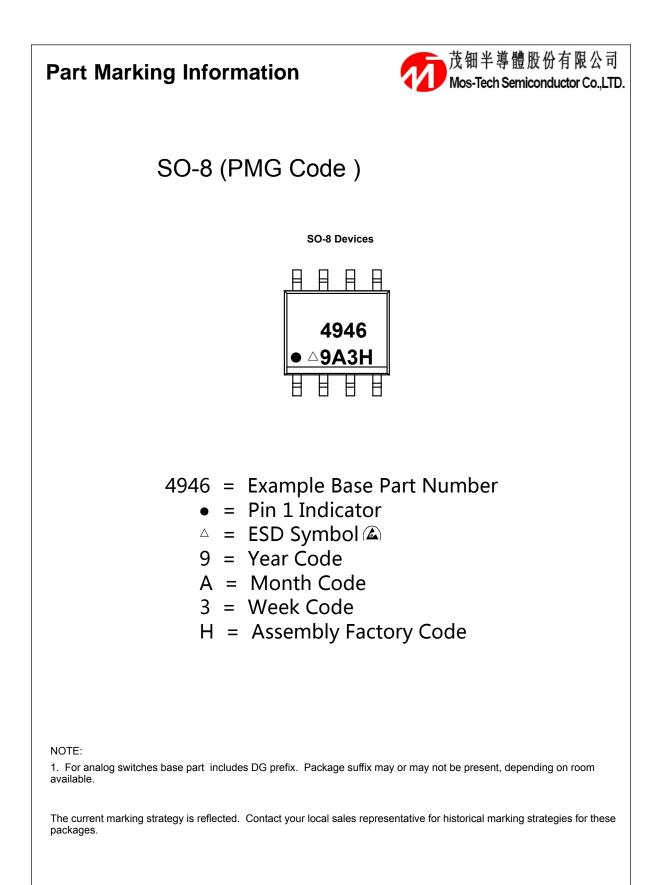


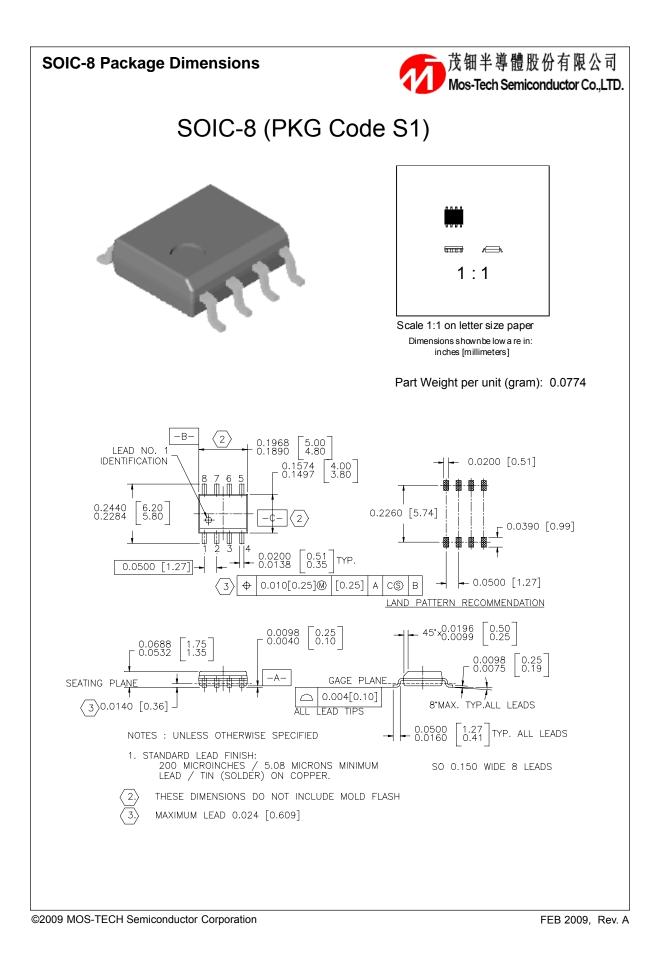
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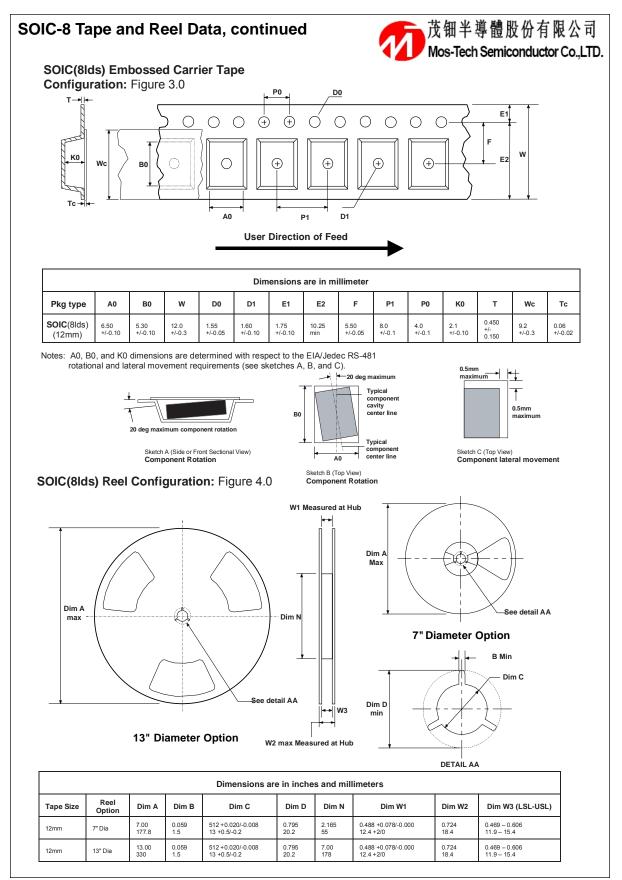












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